MOTDONIV	Add:	Room 1405A, Building Park, GuangMing Distric	1B, Hua q t, Shenzh	iang Idea en, China
VICTRONIX	Tel:	+86-755-33265935	Fax:	+86-755-33265935

SPECIFICATION

VXT350MQHI-03C

	relim	inary	Spec	eifica	tion
□ F	Final S	Specif	icatio	on	



Approved By:	
Date:	

RECORD OF REVISION

Rev No.	Rev Date	Page	Contents	Editor
V00	2024/12/04		New issue.	Solon

TABLE OF CONTENTS

List	Description	Page No.
	Cover	1
	Revision Record	2
	Table of Contents	3
1	Scope	4
2	General Information	4
3	External Dimensions	5
4	Interface Description	6-7
5	Absolute Maximum Ratings	8
6	Electrical Specifications	9
7	Timing Characteristics	10-17
8	Backlight Characteristics	18
9	Optical Characteristics	19-21
10	Reliability Test Conditions and Methods	22
11	Inspection Standard	23-27
12	Handling Precautions	28-28
13	Precaution for Use	29-30

1. Scope

This specification defines general provisions as well as inspection standards for TFT module supplied by Victronix Tecenstar INT'L Co., LTD.

If the event of unforeseen problem or unspecified items may occur, naturally shall negotiate and agree to solution.

2. General Specifications

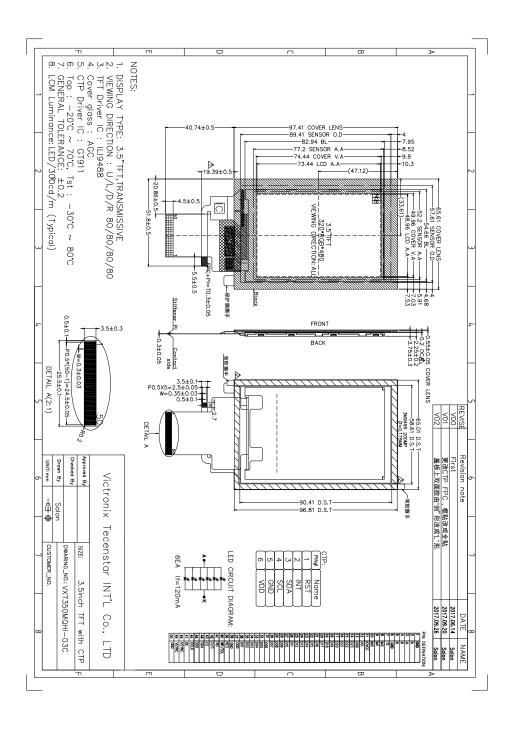
2.1 LCD Parameter

Item	Contents	Unit	Note
LCD Type	TFT	-	
Display color	16.7M		
Viewing Direction	ALL	O'Clock	
Grayscale inversion direction	-	O'Clock	
Operating temperature	-20~+70	°C	
Storage temperature	-30~+80	°C	
Module size	3.5	inch	
Active Area(W×H)	48.96x73.44	mm	
Number of Dots	320x480	dots	
Controller	ILI9488	-	
Power Supply Voltage	3.3	V	
Outline Dimensions	65.61x97.41x3.75	mm	
Backlight	1x6-LEDs (white)	pcs	
Weight		g	
Interface	RGB	-	

2.2 CTP Parameter

Item	Contents	Unit	Note
Cover View Area	49.96(H)x74.44(V)		
CTP Resolution	320x480	dots	
Interface Mode	IIC		
Touch Mode	5 Human fingers multi-touch	-	
Surface hardness	>=7H	-	
Transparency	>=85%	-	
Accuracy	Center +/-1.5mm,Edge +/-2.5mm	mm	
CTP Controller	GT911	-	
Power Supply Voltage	3.3	V	

3. Outline Drawing



4.Interface Description

4.1 LCD interface

Pin No.	Symbol	1/0	Function					
1	GND	Р	Ground.					
2~3	Α	Р	LED back light(Anode)					
4~5	K	Р	LED back light(Cathode)					
6	GND	Р	Ground.					
7	TE	0	Serve as a TE(Tearing effect) output signal					
8	IM2	ı	Select the interface mode					
9	IM1	I	0 0 0 MIPI-DBI Type B 24-bit bus (DB_EN = 1) 0 0 0 MIPI-DBI Type B 18-bit bus (DB_EN = 0) 0 0 1 MIPI-DBI Type B 9-bit bus 0 1 0 MIPI-DBI Type B 16-bit bus					
10	IM0	ı	0 1 MIPI-DBI Type B 8-bit bus 1 0 1 MIPI-DBI Type C Option 1 (3-line SPI) 1 1 0 MIPI-DBI Type C Option 3 (4-line SPI) 1 1 1 MIPI-DBI Type C Option 3 (4-line SPI)					
11	IOVCC	Р	Digital IO Pad power supply(1.8V&2.8V)					
12	VCI	Р	Power supply (2.8V)					
13	GND	Р	Ground.					
14-37	D23-D00	ı	Data pin					
38	GND	Р	Ground.					
39	RES	ı	Reset the display					
40	WR/SCL	ı	Write enable pin 180 parallel bus system interface/Serial clock as					
41	RD	ı	Read signal.					
42	D/C	1	Data/Command selection pin.					
43	CS	1	Chip select signal					
44	SDA	ı	Serial Input data bus					
45	SDO	ı	Serial output data bus					
46	DCLK	ı	Data clock					
47	DE	I	Data enable pin					
48	HSYNC	ı	Line sync signal					
49	VSYNC	I	Frame sync signal					
50	GND	Р	Ground.					

4.2 CTP pin

Pin No.	Symbol	1/0	Function
1	RST	1	Reset the display
2	INT	ı	External Interrupt to the IC of CTP
3	SDA	I/O	Serial Input/output data bus
4	SCL	1	Serial clock
5	GND	Р	Ground
6	VDD	Р	CTP Power supply

5. Absolute Maximum Ratings(Ta=25°C)

5.1 Electrical Absolute Maximum Ratings.(Vss=0V ,Ta=25°C)

Item	Symbol	Min.	Max.	Unit	Note
	VCI	0.3	2.2		
Power Supply Voltage	IOVCC	-0.3	3.3	V	1, 2
	V _{GH} -V _{GL}	-	32		

Notes:

- If the module is above these absolute maximum ratings. It may become permanently damaged. Using the module within the following electrical characteristic conditions are also exceeded, the module will malfunction and cause poor reliability.
- 2. $V_{DD} > V_{SS}$ must be maintained.

5.2 Environmental Absolute Maximum Ratings.

	Stor	age	Operat	ing		
Item	MIN.	MAX.	MIN.	MAX.	Note	
Ambient Temperature	-30℃	80 °C	- 20 °C	70 °C	1,2	
Humidity	-	-	-	-	3	

- 1. The response time will become lower when operated at low temperature.
- 2. Background color changes slightly depending on ambient temperature.

The phenomenon is reversible.

3. Ta<=40°C:85%RH MAX.

Ta>=40°C:Absolute humidity must be lower than the humidity of 85%RH at 40°C.

6. Electrical Specifications and Instruction Code

6.1 Electrical characteristics(Vss=0V ,Ta=25°C)

Parameter	Parameter Symb		Condition	Min	Тур	Max	Unit	Note
		VCI	Ta=25°C	2.5	2.8	3.3	V	1
Power suppl	У	IOVCC	1d=25 C	1.65	1.8 3.3			
logut valtage	'H'	V _{IH}	VDD-3 3V	0.7 _{IOVCC}	-	IOVCC	V	-
Input voltage	ΊĽ	V _{IL}	VDD=3.3V	-0.3	-	0.3IOVCC	V	-
Outrot valta a	'H'	V _{OH}	IOH= -1.0mA	0.8 _{IOVCC}	-	IOVCC	V	-
Output voltage	'L'	V _{OL}	IOL= +1.0mA	0	-	0.2IOVCC	V	-

Note:

^{1:}When an optimum contrast is obtained in transmissive mode.

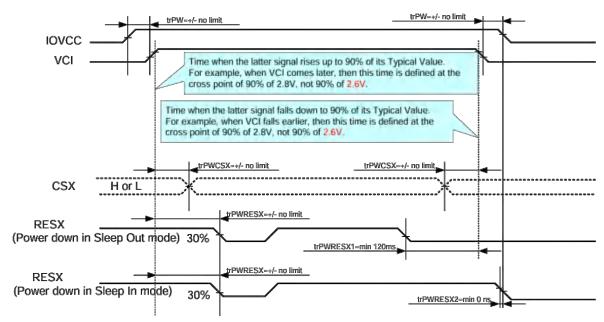
^{2:} Tested in 1×1 chessboard pattern.

7. Timing Characteristics

7.1 POWER ON/OFF SEQUENCE

7.1.1 Case 1 – RESX line is held high or unstable by host at power on:

If the RESX line is held High or unstable by the host during Power On, then Hardware Reset must be applied after both VCI and IOVCC have been applied. Otherwise, the correct functionality is not guaranteed. There is no timing restriction upon this hardware reset.

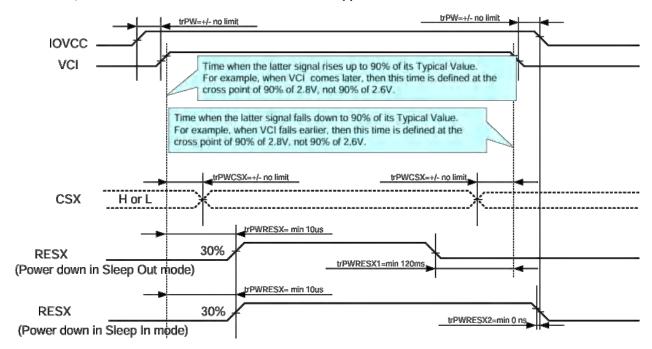


trPWRESX1 is applied to RESX falling in the Sleep Out Mode trPWRESX2 is applied to RESX falling in the Sleep In Mode

Note: Unless otherwise specified, timings herein show the cross point at 50% of the signal power level.

7.1.2 Case 2 – RESX line is held low or unstable by host at power on

If the RESX line is held Low (and stable) by the host during Power On, then the RESX must be held low for a minimum of 10µsec after both VCI and IOVCC have been applied.



trPWRESX1 is applied to RESX falling in the Sleep Out Mode trPWRESX2 is applied to RESX falling in the Sleep In Mode

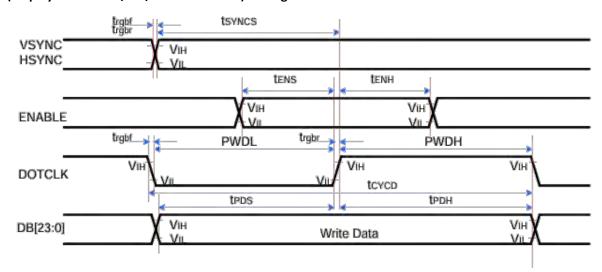
Note: Unless otherwise specified, timings herein show the cross point at 50% of the signal power level.

7.1.3 Uncontrolled Power Off

The Uncontrolled Power Off means the situation when a battery is removed without the controlled power of sequence. There wil not be any damages on the display module, or the display module will not cause any damages on the host or lines of the interface. At an uncontrolled power of event, the ILI9488 will force the display to become blank and will not cause any abnormal visible effects within 1 second on the display and remains blank until "Power On Sequence" powers it up.

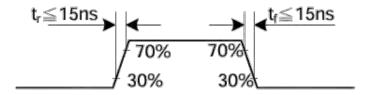
7.2 AC Characteristics

7.2.1 DPI (Display Parallel 16-/18-/24-bit interface) Timing Characteristics



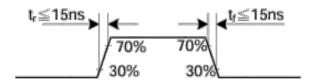
Signal	Symbol	Parameter	min	max	Unit	Description
VSYNC/	tsviics	VSYNC/HSYNC setup time	15	=	пs	
HSYNC	tsynch	VSYNC/HSYNC hold time	15	=	пѕ	
	tens	ENABLE setup time	15	- m	ns	
ENABLE tenh	TENH	ENABLE hold time	15		ns	
ENABLE tens tens tens tens tens tens tens tens	teos	Data setup time	15		ns	16-/18-/24-bit bus
	t _{PDH}	Data hold time	15	-	ns	RGB interface mod
	PWDH	DOTCLK high-level period	20		ns	
DOTO! II	PWDL	DOTCLK low-level period	20	-	ns	
DOTCLK	teven	DOTCLK cycle time	50	==	ns	
	t _{rate} , t _{rate}	DOTCLK,HSYNC,VSYNC rise/fall time		15	ns]

Note: Ta = -40 to 85 °C, IOVCC = 1.65V to 3.3V, VCI = 2.5V to 3.3V, AGND = DGND = 0V

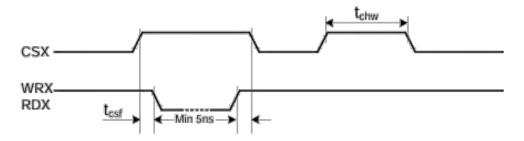


Notes:

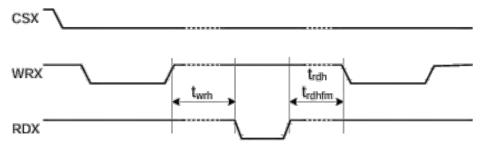
- 1. Ta = -40 to 85 °C, IOVCC = 1.65V to 3.3V, VCI = 2.5V to 3.3V, AGND = DGND = 0V
- 2. Logic high and low levels are specified as 30% and 70% of IOVCC for input signals.
- 3. Input signal rising time and falling time:



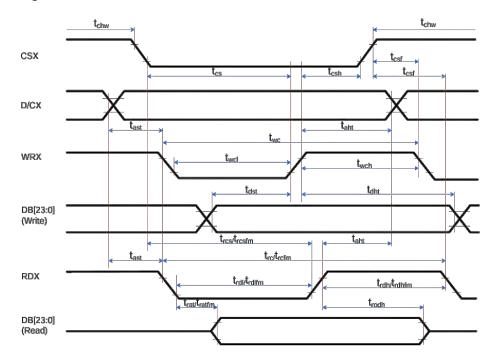
7. The CSX timing:



8. The Write to Read or the Read to Write timing:

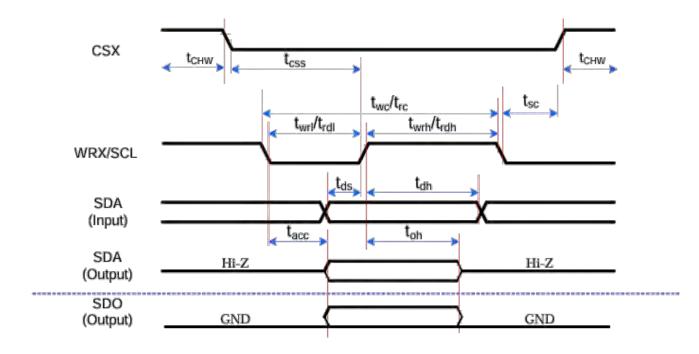


7.2.2 DBI Type B Timing Characteristics



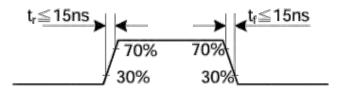
Signal	Symbol	Parameter	min	max	Unit	Description
DOV	tast	Address setup time	0	-	ns	-
DCX	taht	Address hold time (Write/Read)	0	-	ns	-
	tchw	CSX "H" pulse width	0	-	ns	-
	tcs	Chip Select setup time (Write)	15	-	ns	-
CSX	trcs	Chip Select setup time (Read ID)	45	-	ns	-
	trcsfm	Chip Select setup time (Read FM)	355	-	ns	-
	tcsf	Chip Select Wait time (Write/Read)	0	-	ns	-
	twc	Write cycle	40	-	ns	-
WRX	twrh	Write Control pulse H duration	15	-	ns	-
	twrl	Write Control pulse L duration	15	-	ns	-
	trcfm	Read Cycle (FM)	450	-	ns]
RDX (FM)	trdhfm	Read Control H duration (FM)	90	-	ns	When read from Frame Memory
	trdlfm	Read Control L duration (FM)	355	-	ns	Wellory
	trc	Read cycle (ID)	160	-	ns	
RDX (ID)	trdh	Read Control pulse H duration	90	-	ns	When read ID data
	trdl	Read Control pulse L duration	45	-	ns	
DB [23:0],	tdst	Write data setup time	10	-	ns	
DB [23:0], DB [17:0],	tdht	Write data hold time	10	-	ns]
DB [15:0],	trat	Read access time	-	40	ns	For maximum, CL=30pF For minimum, CL=8pF
DB [8:0],	tratfm	Read access time	-	340	ns	To minimum, CL=Opi
DB [7:0]	trod	Read output disable time	20	80	ns	

7.2.3 DBI Type C Option 1(3-Line SPI System) Timing Characteristics



Signal	Symbol	Parameter	min	max	Unit	Description
	tsc	SCL-CSX	15	=	ns	
ocu	tchw	CSX H Pulse Width	40	8	ns	
CSX	tcss	Chip select time (Write)	60	=	ns	
	tcsh	Chip select hold time (Read)	65	- ns		
	twc	Serial Clock Cycle (Write)	66	8	ns	
	twrh	SCL H Pulse Width (Write)	15	=	ns	
601	twrl	SCL L Pulse Width (Write)	15	-	ns	
SCL	trc	Serial Clock Cycle (Read)	150		ns	
	trdh	SCL H Pulse Width (Read)	60	-	ns	
	trdl	SCL L Pulse Width (Read)	15 - se Width 40 - time (Write) 60 - hold time (Read) 65 - s Cycle (Write) 66 - e Width (Write) 15 - e Width (Write) 15 - e Width (Read) 60 - e Width (Read) 10 - e (Read) 10 - e (Read) 10 - e (Read) 10 -	-	ns	
SDA	tds	Data setup time (Write)	10		ns	
(Input)	tdh	Data hold time (Write)	10		ns	
SDA/SDO	tacc	Access time (Read)	10	50	ns	For maximum CL=30pF
(Output)	toh	Output disable time (Read)	15	50	ns	For minimum CL=8pF

Note: Ta = -40 to 85 °C, IOVCC = 1.65V to 3.3V, VCI = 2.5V to 3.3V, AGND = DGND = 0V, T = 10+/-0.5ns



CSX t_{csh} t_{CHW} t_{CHW} t_{css} D/CX t_{ah} twc/trc twri/trdi twrh/trdh WRX/SCL t_{ds} t_{dh} SDA (Input) tacc t_{oh} SDA Hi-Z Hi-Z (Output) SDO (Output) GND GND

7.2.4 DBI Type C Option 3(4-Line SPI System) Timing Characteristics

Signal	Symbol	Parameter	min	max	Unit	Description
	tcss	Chip select time (Write)	15		ns	
CSX SCL D/CX SDA (Input)	tcsh	Chip select hold time (Read)	15		ns	
	tCHW	CS H pulse width	40	-	ns n	
	twc	Serial clock cycle (Write)	50	-	ns	
CSX SCL D/CX SDA (Input) SDA/SDO	twrh	SCL H pulse width (Write)	10		ns	
	twrl	SCL L pulse width (Write)	10	■	ns	
	trc	Serial clock cycle (Read)	150	-	ns	
	trdh	SCL H pulse width (Read)	60	∞	ns	
	trdl	SCL L pulse width (Read)	60		ns	
D.(O)	tas	D/CX setup time	10		ns	
D/GX	tah	D/CX hold time (Write/Read)	10		ns	
SDA	tds	Data setup time (Write)	10		ns	
(Input)	tdh	Data hold time (Write)	10		ns	
SDA/SDO	tacc	Access time (Read)	10	50	ns	For maximum CL=30pF
D/CX SDA (Input)	tod	Output disable time (Read)	15	50	ns	For minimum CL=8pF

Notes:

- 3. Ta = -40 to 85 °C, IOVCC = 1.65V to 3.3V, VCI = 2.5V to 3.3V, AGND = DGND = 0V, T = 10+/-0.5ns.
 - 2. Does not include signal rising and falling times.

7.3 Reset timing characteristics

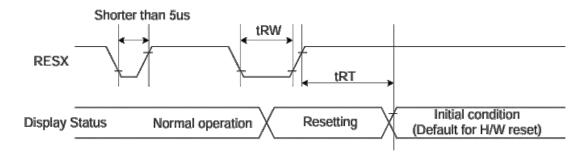


Table 39: Reset Timing

Signal	Symbol	Parameter	Min	Max	Unit
	tRW	Reset pulse duration	10		uS
RESX				5 (note 1,5)	m\$
	tRT	Reset cancel		120 (note 1,6,7)	m\$

Notes:

- The reset cancel also includes the required time for loading ID bytes, VCOM setting and other settings from the EEPROM to registers. After a rising edge of RESX, this loading is done within 5 ms after the H/W reset cancel (tRT).
- According to the Table 40, a spike due to an electrostatic discharge on the RESX line does not cause irregular system reset.

Table 40: Reset Description

RESX Pulse	Action
Shorter than 5us	Reset Rejected
Longer than 9us	Reset
Between 5us and 9us	Reset starts

- During the Reset period, the display will be blanked (When Reset starts in the Sleep Out mode, the display will enter the blanking sequence in at least 120 ms. The display remains the blank state in the Sleep In mode.) and then return to the default condition for the Hardware Reset.
- 4. Spike Rejection can also be applied during a valid reset pulse, as shown below:

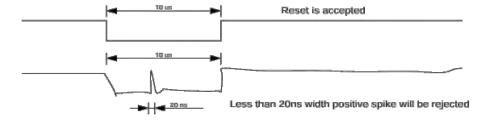
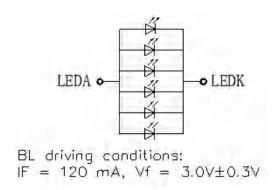


Figure 135: Positive Noise Pulse during Reset Low

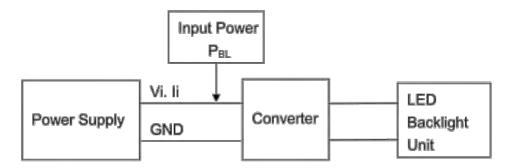
8.0 Backlight Characteristic



Item	Symbol	Min	Тур	Max	Unit	Test Condition
Supply Voltage	Vf	-	3.0	-	V	Note 1
Supply Current	If	-	120	-	mA	Note 2
Power dissipation	P_{BL}	-	360	-	mW	
Life Time	-	30000	-	-	Hr	Note 3,4
Backlight Color	White					

Note 1: The LED Supply Voltage is defined by the number of LED at Ta=25°C and If =120mA.

Note 2: LED current is measured by utilizing a high frequency current meter as shown below:



Note 3: The "LED life time" is defined as the module brightness decrease to 50% original brightness at Ta=25°C and If =120mA. The LED lifetime could be decreased if operating If is larger than 120mA. Note 4: LED light bar circuit:

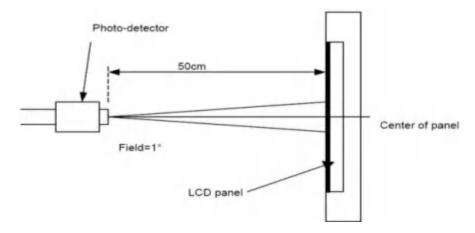
9. Optical Characteristics

Item	Syn	nbol	Condition	Min.	Тур.	Max.	Unit	Note
Brightness	Е	Вр	lf=120mA	250	300	-	Cd/m ²	1
Uniformity	Δ	Вр	II=120MA	80	-	-	%	1,2
	3:	00		-	80	-		
Viewine Angle	6:	00	C => 10	-	80	-	D	4.2
Viewing Angle	9:	00	Cr≥10	-	80	-	Deg	1,2
	12:00			-	80	-		
Contrast Ratio	(Cr	θ=0°	-	700	-	-	3,4
Response Time	Tr	+T _f	Ф=0°	-	30	-	ms	4,5
	W	х		0.2253	0.2753	0.3253	-	
	"	У		0.2402	0.2902	0.3402	-	
	R	х		0.5805	0.6305	0.6805	-	
Color of CIE	, r	У		0.3018	0.3518	0.4018	-	
Coordinate	G	x (θ=0° Φ=0°	0.2738	0.3238	0.3738	-	1,6
	0	У	Ψ-0	0.5268	0.5768	0.6268	-	
	В	х		0.0887	0.1387	0.1887	-	
	В	у		-	0.0410	0.0910	-	
NTSC Ratio		S		-	60	-	%	

^{*}The parameter is slightly changed by temperature, driving voltage and materiel

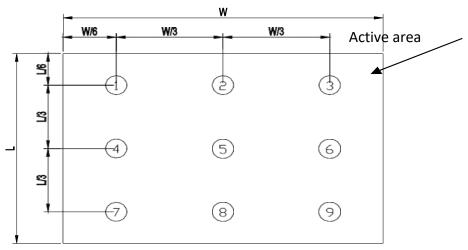
Note 1: The data are measured after LEDs are turned on for 5 minutes. LCM displays full white. The brightness is the average value of 9 measured spots. Measurement equipment CA310 Measuring condition:-Measuring surroundings: Dark room.-Measuring temperature: Ta=25°C.-Adjust operating voltage to get optimum contrast at the center of the display.

The measured value is more than 5 minutes at the center point of the LCD panel, and the backlight is turned on at the same time.

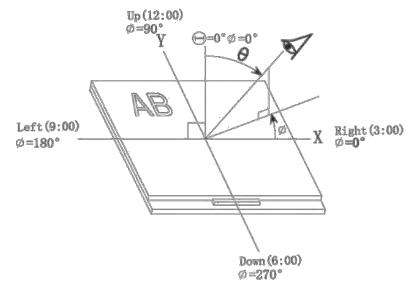


Note 2: The luminance uniformity is calculated by using following formula.

△Bp = Bp (Min.) / Bp (Max.)×100 (%);Bp (Max.) = Maximum brightness in 9 measured spots Bp (Min.) = Minimum brightness in 9 measured spots.



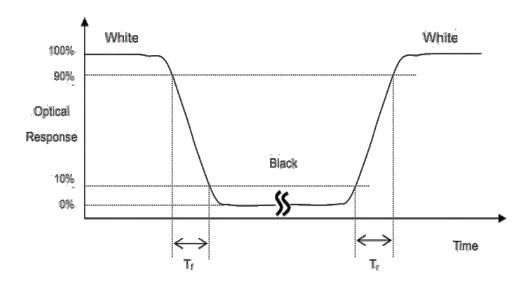
Note 3: The definition of viewing angle:Refer to the graph below marked by θ and Φ



Page:20/30

Note 4: Definition of contrast ratio Contrast measurements shall be made at viewing angle of Θ = 0 and at the center of the LCD surface. Luminance shall be measured with all pixels in the view field set first to white, then to the dark (black) state.

Note 5: Definition of Response time The output signals of photo detector are measured when the input signals are changed from "white" to "black"(Tf) and from "black" to "white"(Tr), respectively. The response time is defined as the time interval between the 10% and 90% of amplitudes. Refer to figure as below.



10. Reliability Test Conditions and Methods

No.	Test Items	Test Condition	Inspection After Test
1	High Temperature Storage	80°C±2°C×96Hours	Inspection after 2~4hours storage at room temperature, the
2	Low Temperature Storage	-30°C±2°C×96Hours	samples should be free from
3	High Temperature Operating	70°C±2°C×96Hours	defects: 1, Air bubble in the LCD.
4	Low Temperature Operating	-20°C±2°C×96Hours	2, Seal leak.
(5)	Temperature Cycle(Storage)	-30°C 80°C (30min) (5min) (30min) 1cycle Total 10cycle.	 3, Non-display. 4, Missing segments. 5, Glass crack. 6, Current IDD is twice higher than initial value.
6	Damp Proof Test (Storage)	60°C±5°C×90%RH×96Hours	7, The surface shall be free from damage. 8, The electric characteristic requirements shall be satisfied. 9.Brightness reduction more than 50%.

REMARK:

- 1, The Test samples should be applied to only one test item.
- 2, Sample side for each test item is 5~10pcs.
- 3, For Damp Proof Test, Pure water (Resistance $> 10 M\Omega$) should be used.
- 4,In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judge as a good part.
- 5, EL evaluation should be accepted from reliability test with humidity and temperature: Some defects such as black spot/blemish can happen by natural chemical reaction with humidity and Fluorescence EL has.
- 6, Failure Judgment Criterion: Basic Specification Electrical Characteristic, Mechanical Characteristic, Optical Characteristic.

11. Inspection Standard

11.1 Scope

Specifications contain

11.1.1 Display Quality Evaluation

11.1.2 Mechanics Specification

11.2 Sampling Plan

Unless there is other agreement, the sampling plan for incoming inspection shall follow

MIL-STD-105E.

11.2.1 Lot size: Quantity per shipment as one lot (different model as different lot).

11.2.2 Sampling type: Normal inspection, single sampling.

11.2.3 Sampling level: Level II.

11.2.4 AQL: Acceptable Quality Level

Major defect: AQL=0.65 Minor defect: AQL=1.5

11.3 Panel Inspection Condition

11.3.1 Environment:

Room Temperature: 25±5°C.

Humidity: 65±5% RH.

Illumination: 300 ~ 700 Lux.

11.3.2 Inspection Distance:

35±5 cm

11.3.3 Inspection Angle:

The vision of inspector should be perpendicular to the surface of the Module.

11.3.4 Inspection time:

Perceptibility Test Time: 20 seconds max.

11.4 Inspection Plan

Class	ltem	Judgment	Class
	1. Outside and inside package.	"MODEL NO.", "LOT NO." and "QUANTITY" should indicate on the package.	Minor
Packing & Indicate	2. Model mixed and quantity.	Other model mixed Quantity short or over	Major
	3. Product indication.	"MODEL NO." should indicate on the product.	Major
Assembly	4. Dimension, LCD glass scratch and scribe defect.	According to specification or drawing.	Major
	5. Viewing area.	Polarizer edge or LCD's sealing line is visible in the viewing areaRejected.	Minor
	6. Blemish, black spot, white spot in the LCD and LCD glass cracks.	According to standard of visual inspection.(inside viewing area)	Minor
Appearance	7. Blemish, black spot, white spot and scratch on the polarizer.	According to standard of visual inspection.(inside viewing area)	Minor
	8. Bubble in polarizer.	According to standard of visual inspection.(inside viewing area)	Minor
	9. LCD's rainbow color.	Strong deviation color (or newton ring) of LCDRejected. Or according to limited sample.(if needed, and inside viewing area)	Minor
	10. Electrical and optical characteristics.(contrast Vop chromaticityetc)	According to specification or drawing.(inside viewing area)	Major
Electrical	11. Missing line.	Missing dot line character	Major
	12.Short circuit. Wrong pattern display.	No display, wrong pattern display, current consumption. Out of specification	Major

13. Dot defect.(for color and TFT)	According to standard of visual Inspection.	Minor
------------------------------------	---	-------

11.5 Standard Of Visual Inspection

NO.	CLASS	ITEM		JUDGMENT						
			(A) Round type:				Unit: mm			
				Di	ameter (mm.)		Acceptable Q'ty			
					Ф≦0.1		Disregard			
		Black and white spot.			0.1 < Φ≦0.25	2(Distance>10mm)			
		Foreign materiel.			0.25 < Ф		0			
11.5.1	Minor	Dust.			Φ = (length+width	1)/2				
11.5.1	IVIIIIOI	Blemish.	(B) Line	ar typ	e:		Unit: mm			
		Scratch.	Lei	ngth	Width (mm.)		Acceptable Q'ty	e Q'ty		
		Scratch.			W≦0.03	Disregard				
			L≦3.0		0.03< W≦0.0	5	1(Distance>10mm))		
				0.05 < W			Not allow			
							Unit: mm.			
					Diameter		Acceptable Q'ty			
11.5.2	Minor	Dent on polarizer.			Disregard					
					0.1 < Φ≦0.25	2(Distance>10mm)			
					0.25 < Ф		0			
							Unit: mm.			
					Diameter		Acceptable Q'ty			
11.5.3	Minor	Bubble in polarizer.			Ф≦0.1		Disregard			
					0.1< Φ≦0.25	2(Distance>10mm)			
					0.25 < Ф		0			
					0.25 < Ф		0			

		ī	
			Items Acceptable Q'ty
			Bright dot N ≦3
			Dark dot N ≦3
			Total dot N ≦6
11.5.4	Minor	Dot defect	Pixel define: Dot Dot Dot Note1: The definition of dot: The size of a defective dot over 1/2 of whole dot is regarded as one defective dot. Note 2: Bright dot: Dots appear bright and unchanged in size in which LCD panel is displaying under black pattern. Note 3: The bright dot defect must be visible through 2% ND filter Note 4: Dark dot: Dots appear dark and unchanged in size in which LCD panel is displaying under pure red, green, blue
11.5.5	Minor	LCD glass chipping.	Y>S Reject
11.5.6	Minor	LCD glass chipping.	X or Y>S Reject
11.5.7	Major	LCD glass crack.	T Y>(1/2) T Reject
11.5.8	Major	LCD glass scribe defect.	1. a>L/3, A>1.5mm Reject 2. B : According to dimension

11.5.9	Minor	LCD glass chipping. (on the terminal area)	$\Phi = (x+y)/2>2.5 mm$ Reject
11.5.10	Minor	LCD glass chipping. (on the terminal surface)	T Y>(1/3)T Reject
11.5.11	Minor	LCD glass chipping.	T Y>T Reject

12. Handling Precautions

12.1 Mounting method

This TFT module consists of two thin glass plates with polarizes which easily be damaged. And

since the module in so constructed as to be fixed by utilizing fitting holes in the printed circuit board.

Extreme care should be needed when handling the LCD modules.

12.2 Caution of LCD handling and cleaning

When cleaning the display surface, Use soft cloth with solvent

[Recommended below] and wipe lightly.

- Isopropyl alcohol.
- Ethyl alcohol.

Do not wipe the display surface with dry or hard materials that will damage the polarizer surface. Do not use the following solvent:

- Water.
- Aromatics.

Do not wipe ITO pad area with the dry or hard materials that will damage the ITO patterns Do not use the following solvent on the pad or prevent it from being contaminated:

- Soldering flux.
- Chlorine (Cl), Sulfur (S).

If goods were sent without being silicon coated on the pad, ITO patterns could be damaged due to the corrosion as time goes on.

If ITO corrosion happen by miss-handling or using some materials such as Chlorine (CI), Sulfur (S) from customer, Responsibility is on customer.

12.3 Caution against static charge

The LCD module use C-MOS LSI drivers, so we recommended that you:

Connect any unused input terminal to POWER or GROUND, do not input any signals before power is turned on, and ground your body, work/assembly areas, and assembly equipment to protect against static electricity.

12.4 packing

- Module employs LCD elements and must be treated as such.
- Avoid intense shock and falls from a height.
- To prevent modules from degradation, do not operate or store them exposed direct to sunshine or high temperature/humidity.

12.5 Caution for operation

- It is an indispensable condition to drive LCD's within the specified voltage limit since the higher voltage then the limit cause the shorter LCD life.
- An electro chemical reaction due to direct current causes LCD's undesirable deterioration, so that the use of direct current drive should be avoided.
- Response time will be extremely delayed at lower temperature then the operating temperature range and on the other hand at higher temperature LCD's how dark color in them. However those phenomena do not mean malfunction or out of order with LCD's, which will come back in the specified operation temperature.
- If the display area is pushed hard during operation, some font will be abnormally displayed but it resumes normal condition after turning off once.
- Slight dew depositing on terminals is a cause for electro-chemical reaction resulting in terminal open circuit.

Usage under the maximum operating temperature, 50%Rh or less is required.

12.6 storing

In the case of storing for a long period of time for instance, for years for the purpose or replacement use, the following ways are recommended.

- Storage in a polyethylene bag with the opening sealed so as not to enter fresh air outside in it. And with no desiccant.
- Placing in a dark place where neither exposure to direct sunlight nor light's keeping the storage temperature range.
- Storing with no touch on polarizer surface by the anything else.
 [It is recommended to store them as they have been contained in the inner container at the time of delivery from us.

12.7 Safety

- It is recommendable to crash damaged or unnecessary LCD's into pieces and wash off liquid crystal by either of solvents such as acetone and ethanol, which should be burned up later.
- When any liquid leaked out of a damaged glass cell comes in contact with your hands, please wash
 it off well with soap and water.

13. Precaution for Use

13.1

A limit sample should be provided by the both parties on an occasion when the both parties agreed its necessity. Judgment by a limit sample shall take effect after the limit sample has been established and confirmed by the both parties.

13.2

On the following occasions, the handing of problem should be decided through discussion and agreement between responsible of the both parties.

- When a question is arisen in this specification
- When a new problem is arisen which is not specified in this specifications
- When an inspection specifications change or operating condition change in customer is reported to TFT, and some problem is arisen in this specification due to the change
- When a new problem is arisen at the customer's operating set for sample evaluation in the customer site.

- END